


<b>Search Notes</b>  	<b>Application/Control No.</b>  10607257	<b>Applicant(s)/Patent Under Reexamination</b>  MO, KEE JIN
	<b>Examiner</b>  Hoang, Hieu T	<b>Art Unit</b>  2152

SEARCHED			
Class	Subclass	Date	Examiner
709	223-226, 230-237, 245, 250	2/26/2007	HH

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST search	2/26/2007	HH
IDS search	2/26/2007	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner